

USR Semiconductor Co., Ltd

SYMBOL	CHARACTERISTIC	TEST CONDITIONS	T_J (°C)	VALUE			UNIT
				Min	Type	Max	
$I_{T(RMS)}$	RMS current	50Hz sine wave Double side cooled, $T_{hs}=55^\circ C$	125			629	A
$I_{T(RMS)}$	RMS current	50Hz sine wave Double side cooled, $T_{hs}=80^\circ C$	125			471	A
V_{RRM}	Repetitive peak reverse voltage	V_{RRM} tp=10ms $V_{RSM} = V_{DRM} \& V_{RRM} + 100V$	125	500		1800	V
I_{RRM}	Repetitive peak current	at V_{RRM}	125			30	mA
I_{TSM}	Surge on-state current	10ms half sine wave $V_R=0.6V_{RRM}$	125			2.5	KA
I^2T	I^2T for fusing coordination					31	$A^2s * 10^3$
V_{TO}	Threshold voltage		125			0.99	V
r_T	On-state slop resistance					1.80	$m\Omega$
V_{TM}	Peak on-state voltage	$I_{TM}=500A, F=7.0KN$	125			1.89	V
dv/dt	Critical rate of rise of off-state voltage	$V_{DM}=0.67V_{DRM}$	125			50	V/ μ s
di/dt	Critical rate of rise of on-state current	From 67% V_{DRM} to 1500A, Gate source 1.5A $t_r \leq 0.5\mu s$ Repetitive	125			50	A/ μ s
I_{GT}	Gate trigger current	$V_A=12V, I_A=1A$	25	20		200	mA
V_{GT}	Gate trigger voltage			0.8		2.5	V
I_H	Holding current			20		200	mA
$R_{th(j-h)}$	Thermal resistance Junction to heatsink	At 180° sine double side cooled Clamping force 7.0KN				0.055	°C /W
F_m	Mounting force			5.3		10	KN
T_{stg}	Stored temperature			-40		140	°C
W_t	Weight					80	g
Outline		KT25aT					

Outline

